

## FEATURES

- TIA/EIA RS-485 compliant over full supply range
- 3.0 V to 5.5 V operating voltage range on  $V_{CC}$
- 1.62 V to 5.5 V  $V_{IO}$  logic supply option available
- ESD protection on the bus pins
  - IEC 61000-4-2  $\pm 12$  kV contact discharge
  - IEC 61000-4-2  $\geq \pm 12$  kV air discharge
  - HBM:  $\geq \pm 30$  kV
- Full hot swap support (glitch free power-up/power-down)
- High speed 50 Mbps data rate (ADM3065E/ADM3066E/ADM3067E)
- Low speed 500 kbps data rate for long cables (ADM3061E/ADM3062E/ADM3063E)
- Full receiver short-circuit, open circuit, and bus idle fail-safe
- Extended temperature range up to 125°C
- PROFIBUS compliant at  $V_{CC} \geq 4.5$  V
- Half duplex and full duplex models available
- Allows connection of up to 128 transceivers onto the bus
- Space-saving package options
  - 10-lead, 3 mm  $\times$  3 mm LFCSP
  - 8-lead and 10-lead, 3 mm  $\times$  3 mm MSOP
  - 8-lead and 14-lead, narrow body SOIC

## APPLICATIONS

- Industrial fieldbuses
- Process control
- Building automation
- PROFIBUS networks
- Motor control servo drives and encoders

## FUNCTIONAL BLOCK DIAGRAMS

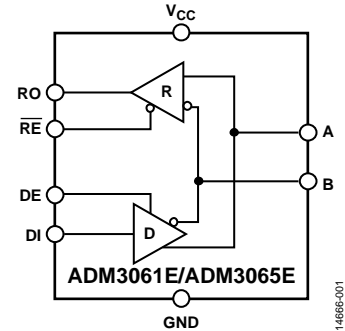


Figure 1. ADM3061E/ADM3065E Functional Block Diagram

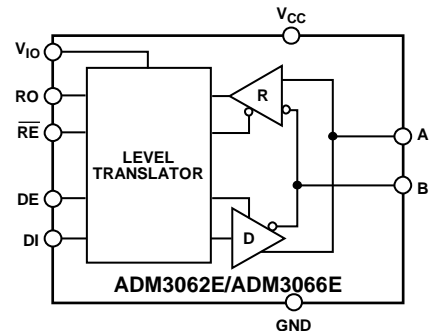


Figure 2. ADM3062E/ADM3066E Functional Block Diagram

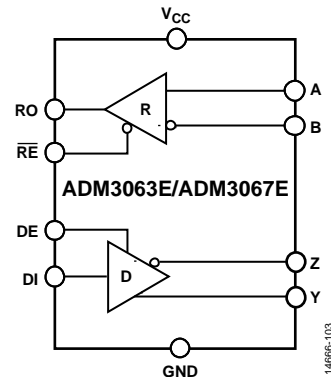


Figure 3. ADM3063E/ADM3067E Functional Block Diagram

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## REVISION HISTORY

### 4/2019—Rev. D to Rev. E

Added ADM3063E .....	Universal
Change to Features Section .....	1
Changes to Figure 3 .....	1
Changes to Table 1 .....	4
Changes to Table 2 .....	5
Added Endnote 1, Table 2; Renumbered Sequentially .....	5
Change to Table 7 .....	11
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Changes to Figure 39 .....	18
Changes to IEC ESD Protected RS-485 Section .....	19
Changes to Truth Tables Section, Table 11, Table 12, and Receiver Fail-Safe Section .....	20
Added Table 10; Renumbered Sequentially .....	20
Changes to Isolated High Speed RS-485 Node Section and Figure 47 .....	22
Changes to Ordering Guide .....	25

### 3/2019—Rev. C to Rev. D

Added ADM3067E and 14-Lead SOIC_N, R-14 .....	Universal
Changes to Feature Section .....	1
Added Figure 3; Renumbered Sequentially .....	1
Moved Table 1 to .....	4
Changes to Table 2 .....	5
Changes to ADM3065E/ADM3066E/ADM3067E Section .....	7
Change to Pin 3, Description Column, Table 7 .....	11
Changes to Figure 10, Figure 11, and Table 8 .....	12

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Moved Test Circuits to .....	18
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### 1/2018—Rev. B to Rev. C

Added ADM3062E .....	Universal
Changes to Figure 2 and Table 1 .....	1
Changes to ADM3061E/ADM3062E Timing Specifications Section and Figure 3 .....	6
Changes to Figure 5 and Figure 6 .....	7
Changes to Figure 9 and Figure 10 .....	11
Changes to Figure 16 and Figure 17 .....	12
Changes to Figure 44 .....	21
Changes to Figure 45 .....	22
Changes to Ordering Guide .....	25

### 12/2017—Rev. A to Rev. B

Added ADM3061E .....	Universal
Changes to Product Title, Features Section, Figure 1, and Table 1 .....	1
Changes to General Description Section .....	3
Changes to Table 2 .....	4
Added ADM3061E Timing Specification Section and Table 3; Renumbered Sequentially .....	6
Moved Figure 3 .....	6
Moved Figure 4, Figure 5, and Figure 6 .....	7
Changes to ADM3065E/ADM3066E Timing Specification Section Title .....	8
Added 10-Lead MSOP Parameter and 10-Lead LFCSP Parameter, Table 5 .....	9
Changes to Operating Temperature Range Parameter, Table 5 and Table 6 .....	9

Changes to Figure 7, Figure 8, and Table 7 .....	10	Moved General Description Section .....	3
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Changes to Figure 11 .....	12	Changes to Specifications Section and Table 2 .....	4
Added Figure 23; Renumbered Sequentially .....	13	Changes to Timing Specifications Section and Figure 3 .....	5
Added Figure 24, Figure 25, Figure 26, Figure 27, and Figure 28... ..	14	Changes to Figure 4, Figure 5, and Figure 6 .....	6
Changed High Speed IEC ESD Protected RS-485 Section to IEC		Added $V_{IO}$ to GND Parameter, Table 4 .....	7
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Changes to Figure 44 .....	21	Added Table 7; Renumbered Sequentially .....	9
Changes to Figure 45 .....	22	Changes to Figure 14, Figure 16, and Figure 17 .....	10
Changes to Ordering Guide .....	25	Changes to Table 8 and Table 9 .....	15
		Added Figure 42 and Figure 43 .....	20
		Changes to Ordering Guide .....	21
<b>5/2017—Rev. 0 to Rev. A</b>			
Added ADM3066E .....	Universal		
Changes to Features Section, Figure 1, and Table 1 .....	1	<b>3/2017—Revision 0: Initial Version</b>	
Added Figure 2; Renumbered Sequentially .....	1		

## GENERAL DESCRIPTION

The ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E are 3.0 V to 5.5 V, IEC electrostatic discharge (ESD) protected RS-485 transceivers, allowing the devices to withstand  $\pm 12$  kV contact discharges on the transceiver bus pins without latch-up or damage. The ADM3062E/ADM3066E feature a  $V_{IO}$  logic supply pin allowing a flexible digital interface capable of operating as low as 1.62 V.

The ADM3065E/ADM3066E/ADM3067E are suitable for high speed, 50 Mbps, bidirectional data communication on multipoint bus transmission lines. The ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E feature a one fourth unit load input impedance, which allows up to 128 transceivers on a bus. The ADM3061E/ADM3062E/ADM3063E models offer all of the same features as the ADM3065E/ADM3066E/ADM3067E models, but at a low 500 kbps data rate suitable for operation over long cable runs.

The ADM3061E/ADM3062E/ADM3065E/ADM3066E are half-duplex RS-485 transceivers, fully compliant to the PROFIBUS® standard with increased 2.1 V bus differential voltage at  $V_{CC} \geq 4.5$  V. The ADM3063E/ADM3067E are full duplex RS-485 transceiver options.

The RS-485 transceivers are available in a number of space-saving packages, such as the 10-lead, 3 mm  $\times$  3 mm LFCSP; the 8-lead or 10-lead, 3 mm  $\times$  3 mm MSOP; and the 8-lead or 14-lead, narrow body SOIC packages. Models with operating temperature ranges of  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  and  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$  are available.

Excessive power dissipation caused by bus contention or by output shorting is prevented by a thermal shutdown circuit. If, during fault conditions, a significant temperature increase is detected in the internal driver circuitry, this feature forces the driver output into a high impedance state.

The ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E guarantee a logic high receiver output when the receiver inputs are shorted, open, or connected to a terminated transmission line with all drivers disabled.

Table 1 presents an overview of the ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E data rate capability across temperature, power supply, and package options. Refer to the Ordering Guide for model numbering.

**Table 1. Summary of the ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3067E Operating Conditions—Data Rate Capability Across Temperature, Power Supply, and Package**

Maximum Data Rate <sup>1</sup>	Maximum $V_{CC}$ (V)	Maximum Temperature	Package Description
50 Mbps	5.5	$-40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$	10-lead LFCSP
50 Mbps	5.5	$-40^{\circ}\text{C}$ to $+105^{\circ}\text{C}$	8-lead SOIC_N, 8-lead MSOP, 10-lead MSOP, and 14-lead SOIC_N
50 Mbps	3.6	$-40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$	8-lead SOIC_N, 8-lead MSOP, 10-lead MSOP, and 14-lead SOIC_N
500 kbps	5.5	$-40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$	8-lead SOIC_N, 8-lead MSOP, 10-lead MSOP, 10-lead LFCSP, and 14-lead SOIC_N

<sup>1</sup> The ADM3065E/ADM3066E/ADM3067E data input (DI) is transmitting 50 Mbps (or 500 kbps for the ADM3061E/ADM3062E/ADM3063E) clock data, and the ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E driver enable (DE) is enabled for 50% of the DI transmit time

## SPECIFICATIONS

$V_{CC} = 3.0\text{ V}$  to  $5.5\text{ V}$ ,  $V_{IO} = 1.62\text{ V}$  to  $V_{CC}$  (ADM3062E/ADM3066E),  $T_A = T_{MIN}$  ( $-40^\circ\text{C}$ ) to  $T_{MAX}$  ( $+125^\circ\text{C}$ ), unless otherwise noted. All typical specifications are at  $T_A = 25^\circ\text{C}$ ,  $V_{IO} = V_{CC} = 3.3\text{ V}$ , unless otherwise noted.

Table 2.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
POWER SUPPLY						
No Load Supply Current	$I_{CC}$		2	7.5	mA	$DE = V_{IO}^1$ , $\overline{RE} = 0\text{ V}$
				7.5	mA	$DE = V_{IO}$ , $\overline{RE} = V_{IO}$
				4.5	mA	$DE = 0\text{ V}$ , $\overline{RE} = 0\text{ V}$
ADM3065E/ADM3066E/ADM3067E Supply Current, Data Rate = 50 Mbps	$I_{CC}$		107	172	mA	load resistance ( $R_L$ ) = $54\ \Omega$ , $DE = V_{IO}$ , $\overline{RE} = 0\text{ V}$ ( $V_{CC} \geq 4.5\text{ V}$ )
			67	75	mA	$R_L = 54\ \Omega$ , $DE = V_{IO}$ , $\overline{RE} = 0\text{ V}$ ( $V_{CC} = 3.0\text{ V}$ )
ADM3061E/ADM3062E/ADM3063E Supply Current, Data Rate = 500 kbps	$I_{CC}$		100	165	mA	$R_L = 54\ \Omega$ , $DE = V_{IO}$ , $\overline{RE} = 0\text{ V}$ ( $V_{CC} \geq 4.5\text{ V}$ )
			56	74	mA	$R_L = 54\ \Omega$ , $DE = V_{IO}$ , $\overline{RE} = 0\text{ V}$ ( $V_{CC} = 3.0\text{ V}$ )
Supply Current in Shutdown Mode	$I_{SHDN}$		210	450	$\mu\text{A}$	$DE = 0\text{ V}$ , $\overline{RE} = V_{IO}$
$V_{IO}$ Shutdown Current <sup>2</sup>	$I_{IO SHDN}$		1	50	$\mu\text{A}$	$DE = 0\text{ V}$ , $\overline{RE} = V_{IO}$
DRIVER						
Differential Outputs						
Output Voltage, Loaded	$ V_{OD2} $	2.0		$V_{CC}$	V	$V_{CC} \geq 3.0\text{ V}$ , $R_L = 50\ \Omega$ , see Figure 36
	$ V_{OD2} $	1.5		$V_{CC}$	V	$V_{CC} \geq 3.0\text{ V}$ , $R_L = 27\ \Omega$ (RS-485), see Figure 36
	$ V_{OD2} $	2.1		$V_{CC}$	V	$V_{CC} \geq 4.5\text{ V}$ , $R_L = 50\ \Omega$ , see Figure 36
	$ V_{OD2} $	2.1		$V_{CC}$	V	$V_{CC} \geq 4.5\text{ V}$ , $R_L = 27\ \Omega$ (RS-485), see Figure 36
	$ V_{OD3} $	1.5		$V_{CC}$	V	$V_{CC} \geq 3.0\text{ V}$ , $-7\text{ V} \leq V_{CM} \leq +12\text{ V}$ , see Figure 37
	$ V_{OD3} $	2.1		$V_{CC}$	V	$V_{CC} \geq 4.5\text{ V}$ , $-7\text{ V} \leq V_{CM} \leq +12\text{ V}$ , see Figure 37
Change in Differential Input Voltage for Complementary Output States	$\Delta V_{OD} $			0.2	V	$R_L = 27\ \Omega$ or $50\ \Omega$ , see Figure 36
Common-Mode Output Voltage	$V_{OC}$			3.0	V	$R_L = 27\ \Omega$ or $50\ \Omega$ , see Figure 36
Change in Common Mode Voltage for Complementary Output States	$\Delta V_{OC} $			0.2	V	$R_L = 27\ \Omega$ or $50\ \Omega$ , see Figure 36
Output Short-Circuit Current	$I_{OS}$	-250		+250	mA	$-7\text{ V} < \text{output voltage } (V_{OUT}) < +12\text{ V}$
ADM3063E/ADM3067E Output Leakage (Y, Z)	$I_O$			+100	$\mu\text{A}$	$DE = 0\text{ V}$ , $\overline{RE} = 0\text{ V}$ , $V_{CC} = 0\text{ V}$ or $3.6\text{ V}$ , input voltage ( $V_{IN}$ ) = $12\text{ V}$
		-100			$\mu\text{A}$	$DE = 0\text{ V}$ , $\overline{RE} = 0\text{ V}$ , $V_{CC} = 0\text{ V}$ or $3.6\text{ V}$ , $V_{IN} = -7\text{ V}$
Logic Inputs (DE, $\overline{RE}$ , DI)						
Input Voltage						
Low	$V_{IL}$			$0.33 \times V_{IO}$	V	$DE, \overline{RE}, DI, 1.62\text{ V} \leq V_{IO} \leq 5.5\text{ V}$
High	$V_{IH}$	$0.67 \times V_{IO}$			V	$DE, \overline{RE}, DI, 1.62\text{ V} \leq V_{IO} \leq 5.5\text{ V}$
Input Current	$I_I$	-2		+2	$\mu\text{A}$	$DE, \overline{RE}, DI, 1.62\text{ V} \leq V_{IO} \leq 5.5\text{ V}, 0\text{ V} \leq V_{IN} \leq V_{IO}$

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
RECEIVER						
Differential Inputs						
Differential Input Threshold Voltage	$V_{TH}$	-200	-125	-30	mV	$-7\text{ V} < \text{common-mode voltage } (V_{CM}) < +12\text{ V}$
Input Voltage Hysteresis	$V_{HYS}$		30		mV	$-7\text{ V} < V_{CM} < +12\text{ V}$
Input Current (A, B)	$I_i$			0.25	mA	$DE = 0\text{ V}, V_{CC} = \text{powered/unpowered}, V_{IN} = 12\text{ V}$
		-0.20			mA	$DE = 0\text{ V}, V_{CC} = \text{powered/unpowered}, V_{IN} = -7\text{ V}$
Line Input Resistance	$R_{IN}$	48			k $\Omega$	$-7\text{ V} \leq V_{CM} \leq +12\text{ V}$
Logic Outputs						
Output Voltage						
Low	$V_{OL}$			0.4	V	$V_{IO} = 3.6\text{ V}$ , output current ( $I_{OUT}$ ) = 2 mA, $V_{ID}^3 \leq -0.2\text{ V}$
				0.4	V	$V_{IO} = 2.7\text{ V}$ , $I_{OUT} = 1\text{ mA}$ , $V_{ID} \leq -0.2\text{ V}^2$
				0.2	V	$V_{IO} = 1.95\text{ V}$ , $I_{OUT} = +500\text{ }\mu\text{A}$ , $V_{ID} \leq -0.2\text{ V}^2$
High	$V_{OH}$	2.4			V	$V_{IO} = 3.0\text{ V}$ , $I_{OUT} = -2\text{ mA}$ , $V_{ID} \geq -0.03\text{ V}$
		2.0			V	$V_{IO} = 2.3\text{ V}$ , $I_{OUT} = -1\text{ mA}$ , $V_{ID} \geq -0.03\text{ V}^2$
		$V_{IO} - 0.2$			V	$V_{IO} = 1.65\text{ V}$ , $I_{OUT} = -500\text{ }\mu\text{A}$ , $V_{ID} \geq -0.03\text{ V}^2$
Short-Circuit Current				85	mA	$V_{OUT} = \text{GND or } V_{IO}$
Three-State Output Leakage	$I_{OZR}$			$\pm 2$	$\mu\text{A}$	$RO = 0\text{ V or } V_{IO}$

<sup>1</sup>  $V_{IO} = V_{CC}$  for ADM3061E/ADM3063E/ADM3065E/ADM3067E.

<sup>2</sup> ADM3062E/ADM3066E only.

<sup>3</sup>  $V_{ID}$  is the receiver input differential voltage.

**TIMING SPECIFICATIONS****ADM3061E/ADM3062E/ADM3063E**

$V_{CC} = 3.0\text{ V}$  to  $5.5\text{ V}$ ,  $V_{IO} = 1.62\text{ V}$  to  $V_{CC}$  (ADM3062E/ADM3066E),  $T_A = T_{MIN}$  ( $-40^\circ\text{C}$ ) to  $T_{MAX}$  ( $+125^\circ\text{C}$ ), unless otherwise noted. All typical specifications are at  $T_A = 25^\circ\text{C}$ ,  $V_{IO} = V_{CC} = 3.3\text{ V}$ , unless otherwise noted.

**Table 3.**

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
<b>DRIVER</b>						
Maximum Data Rate <sup>1</sup>		500			kbps	
Propagation Delay	$t_{DPLH}, t_{DPHL}$		220	800	ns	$R_{LDIFF} = 54\ \Omega$ , $C_{L1} = C_{L2} = 100\text{ pF}$ , see Figure 38
Skew	$t_{DSKEW}$		5	100	ns	$R_{LDIFF} = 54\ \Omega$ , $C_{L1} = C_{L2} = 100\text{ pF}$ , see Figure 38
Rise/Fall Times	$t_{DR}, t_{DF}$	120		800	ns	$R_{LDIFF} = 54\ \Omega$ , $C_{L1} = C_{L2} = 100\text{ pF}$ , see Figure 38
Enable to Output High	$t_{DZH}$			1000	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39
Enable to Output Low	$t_{DZL}$			1000	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39
Disable Time from Low	$t_{DLZ}$			2000	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39
Disable Time from High	$t_{DHZ}$			2000	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39
Enable Time from Shutdown to High	$t_{DZH(SHDN)}^2$			2000	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39
Enable Time from Shutdown to Low	$t_{DZL(SHDN)}^2$			2000	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39
<b>RECEIVER</b>						
Maximum Data Rate		500			kbps	
Propagation Delay	$t_{RPLH}, t_{RPHL}$			200	ns	$C_L = 15\text{ pF}$ , $ V_{ID}  \geq 1.5\text{ V}$ , $V_{CM} = 1.5\text{ V}$ , see Figure 40
Skew/Pulse Width Distortion	$t_{RSKEW}$			50	ns	$C_L = 15\text{ pF}$ , $ V_{ID}  \geq 1.5\text{ V}$ , $V_{CM} = 1.5\text{ V}$ , see Figure 40
Enable to Output High	$t_{RZH}$		10	50	ns	$R_L = 1\text{ k}\Omega$ , $C_L = 15\text{ pF}$ , $ V_{ID}  \geq 1.5\text{ V}$ , DE high, see Figure 42
Enable to Output Low	$t_{RZL}$		10	50	ns	$R_L = 1\text{ k}\Omega$ , $C_L = 15\text{ pF}$ , $ V_{ID}  \geq 1.5\text{ V}$ , DE high, see Figure 42
Disable Time from Low	$t_{RLZ}$		10	50	ns	$R_L = 1\text{ k}\Omega$ , $C_L = 15\text{ pF}$ , $ V_{ID}  \geq 1.5\text{ V}$ , see Figure 42
Disable Time from High	$t_{RHZ}$		10	50	ns	$R_L = 1\text{ k}\Omega$ , $C_L = 15\text{ pF}$ , $ V_{ID}  \geq 1.5\text{ V}$ , see Figure 42
Enable from Shutdown to High	$t_{RZH(SHDN)}^3$			2000	ns	$R_L = 1\text{ k}\Omega$ , $C_L = 15\text{ pF}$ , $ V_{ID}  \geq 1.5\text{ V}$ , see Figure 41
Enable from Shutdown to Low	$t_{RZL(SHDN)}^3$			2000	ns	$R_L = 1\text{ k}\Omega$ , $C_L = 15\text{ pF}$ , $ V_{ID}  \geq 1.5\text{ V}$ , see Figure 41
TIME TO SHUTDOWN	$t_{SHDN}^4$	40			ns	

<sup>1</sup> Maximum data rate assumes a ratio of  $t_{DR}:t_{DIR}:t_{DF}$  equal to 1:0.5:1.

<sup>2</sup>  $t_{DZH(SHDN)}$  and  $t_{DZL(SHDN)}$  refer to the time for the device to enable when DE changes from 0 V to  $V_{CC}$ .  $\overline{RE} = V_{CC}$  for this condition.

<sup>3</sup>  $t_{RZH(SHDN)}$  and  $t_{RZL(SHDN)}$  refer to the time for the device to enable when  $\overline{RE}$  changes from  $V_{CC}$  to 0 V. DE = 0 V for this condition.

<sup>4</sup> Minimum time required to put the device into shutdown: DE and  $\overline{RE}$  must be disabled for more than 40 ns for the device to go into shutdown.

**ADM3065E/ADM3066E/ADM3067E**

$V_{CC} = 3.0\text{ V}$  to  $5.5\text{ V}$ ,  $V_{IO} = 1.62\text{ V}$  to  $V_{CC}$  (ADM3062E/ADM3066E),  $T_A = T_{MIN}$  ( $-40^\circ\text{C}$ ) to  $T_{MAX}$  ( $+125^\circ\text{C}$ ), unless otherwise noted. All typical specifications are at  $T_A = 25^\circ\text{C}$ ,  $V_{IO} = V_{CC} = 3.3\text{ V}$ , unless otherwise noted.

**Table 4.**

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
<b>DRIVER</b>						
Maximum Data Rate <sup>1</sup>		50			Mbps	
Propagation Delay	$t_{DPLH}, t_{DPHL}$		9	15	ns	$R_{LDIFF} = 54\ \Omega$ , $C_{L1} = C_{L2} = 100\text{ pF}$ , see Figure 38
Skew	$t_{DSKEW}$		1	2	ns	$R_{LDIFF} = 54\ \Omega$ , $C_{L1} = C_{L2} = 100\text{ pF}$ , see Figure 38
Rise/Fall Times	$t_{DR}, t_{DF}$		4	6.7	ns	$R_{LDIFF} = 54\ \Omega$ , $C_{L1} = C_{L2} = 100\text{ pF}$ , see Figure 38
Enable to Output High	$t_{DZH}$		10	30	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39
Enable to Output Low	$t_{DZL}$		10	30	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39
Disable Time from Low	$t_{DLZ}$		10	30	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39
Disable Time from High	$t_{DHZ}$		10	30	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39
Enable Time from Shutdown to High	$t_{DZH(SHDN)}^2$			2000	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39
Enable Time from Shutdown to Low	$t_{DZL(SHDN)}^2$			2000	ns	$R_L = 110\ \Omega$ , $C_L = 50\text{ pF}$ , see Figure 39

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
<b>RECEIVER</b>						
Maximum Data Rate		50			Mbps	
Propagation Delay	$t_{RPLH}, t_{RPHL}$			35	ns	$C_L = 15 \text{ pF},  V_{ID}  \geq 1.5 \text{ V}, V_{CM} = 1.5 \text{ V}$ , see Figure 40
Skew/Pulse Width Distortion	$t_{RSKEW}$			3	ns	$C_L = 15 \text{ pF},  V_{ID}  \geq 1.5 \text{ V}, V_{CM} = 1.5 \text{ V}$ , see Figure 40
Enable to Output High	$t_{RZH}$		10	35	ns	$R_L = 1 \text{ k}\Omega, C_L = 15 \text{ pF},  V_{ID}  \geq 1.5 \text{ V}$ , DE high, see Figure 42
Enable to Output Low	$t_{RZL}$		10	35	ns	$R_L = 1 \text{ k}\Omega, C_L = 15 \text{ pF},  V_{ID}  \geq 1.5 \text{ V}$ , DE high, see Figure 42
Disable Time from Low	$t_{RLZ}$		10	35	ns	$R_L = 1 \text{ k}\Omega, C_L = 15 \text{ pF},  V_{ID}  \geq 1.5 \text{ V}$ , see Figure 42
Disable Time from High	$t_{RHZ}$		10	35	ns	$R_L = 1 \text{ k}\Omega, C_L = 15 \text{ pF},  V_{ID}  \geq 1.5 \text{ V}$ , see Figure 42
Enable from Shutdown to High	$t_{RZH(SHDN)}^3$			2000	ns	$R_L = 1 \text{ k}\Omega, C_L = 15 \text{ pF},  V_{ID}  \geq 1.5 \text{ V}$ , see Figure 41
Enable from Shutdown to Low	$t_{RZL(SHDN)}^3$			2000	ns	$R_L = 1 \text{ k}\Omega, C_L = 15 \text{ pF},  V_{ID}  \geq 1.5 \text{ V}$ , see Figure 41
<b>TIME TO SHUTDOWN</b>	$t_{SHDN}^4$	40			ns	

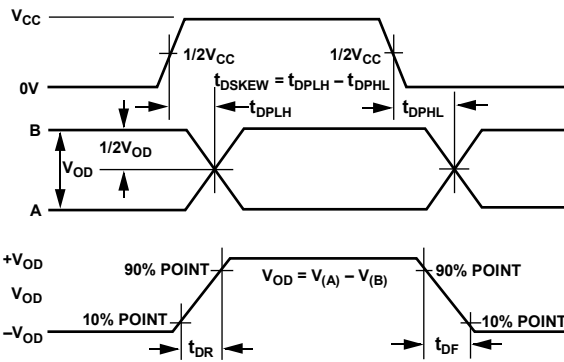
<sup>1</sup> Maximum data rate assumes a ratio of  $t_{DR}:t_{DRF}:t_{DF}$  equal to 1:1:1.

<sup>2</sup>  $t_{DZH(SHDN)}$  and  $t_{DZL(SHDN)}$  refer to the time for the device to enable when  $\overline{DE}$  changes from 0 V to  $V_{CC}$ .  $\overline{RE} = V_{CC}$  for this condition.

<sup>3</sup>  $t_{RZH(SHDN)}$  and  $t_{RZL(SHDN)}$  refer to the time for the device to enable when  $\overline{RE}$  changes from  $V_{CC}$  to 0 V.  $DE = 0 \text{ V}$  for this condition.

<sup>4</sup> Minimum time required to put the device into shutdown:  $\overline{DE}$  and  $\overline{RE}$  must be disabled for more than 40 ns for the device to go into shutdown.

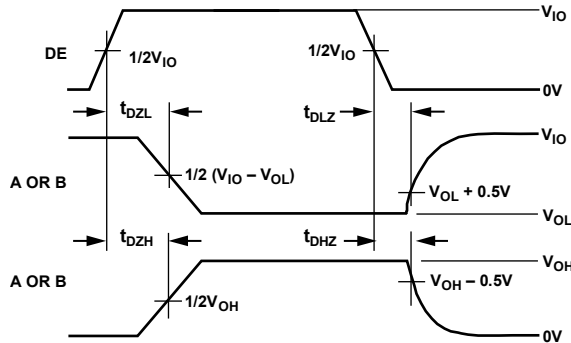
**Timing Diagrams**



**NOTES**

- $V_{OD}$  IS THE DIFFERENCE BETWEEN A AND B, WITH  $+V_{OD}$  BEING THE MAXIMUM POINT OF  $V_{OD}$ , AND  $-V_{OD}$  BEING THE MINIMUM POINT OF  $V_{OD}$ .
- $V_{CC} = V_{IO}$  FOR ADM3062E/ADM3066E.

Figure 4. Driver Propagation Delay Rise and Fall Timing Diagram

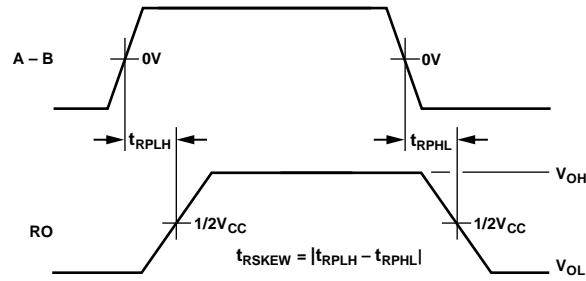


**NOTES**

- $V_{CC} = V_{IO}$  FOR ADM3062E/ADM3066E.

Figure 5. Driver Enable and Disable Timing Diagram

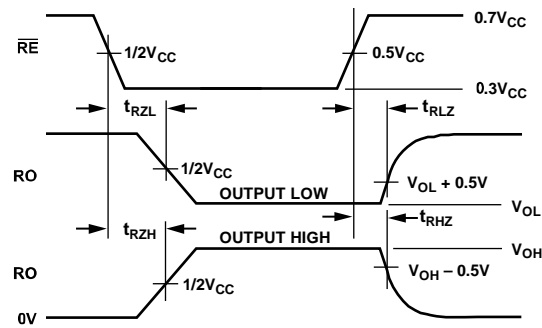




NOTES

1.  $V_{CC} = V_{IO}$  FOR ADM3062E/ADM3066E.

Figure 6. Receiver Propagation Delay Timing Diagram



NOTES

1.  $V_{CC} = V_{IO}$  FOR ADM3062E/ADM3066E.

Figure 7. Receiver Enable and Disable Timing Diagram

## ABSOLUTE MAXIMUM RATINGS

Table 5.

Parameter	Rating
$V_{CC}$ to GND	6 V
$V_{IO}$ to GND	-0.3 V to +6 V
Digital Input and Output Voltage (DE, $\overline{RE}$ , DI, and RO)	-0.3 V to $V_{CC} + 0.3$ V
Driver Output and Receiver Input Voltage	-9 V to +14 V
Operating Temperature Ranges	-40°C to +85°C -40°C to +125°C
Storage Temperature Range	-65°C to +150°C
Continuous Total Power Dissipation	
8-Lead SOIC_N	0.225 W
8-Lead MSOP	0.151 W
10-Lead MSOP	0.151 W
10-Lead LFCSP	0.450 W
14-Lead SOIC_N	0.239 W
Maximum Junction Temperature	150°C
Lead Temperature	
Soldering (10 sec)	300°C
Vapor Phase (60 sec)	215°C
Infrared (15 sec)	220°C
ESD on the Bus Pins (A, B, Y, Z)	
IEC 61000-4-2 Contact Discharge	±12 kV
IEC 61000-4-2 Air Discharge	
10 Positive and 10 Negative Discharges	±12 kV
Three Positive or Three Negative Discharges	±15 kV
ESD Human Body Model (HBM)	
On the Bus Pins (A, B, Y, Z)	≥ ±30 kV
All Other Pins	±8 kV

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

## THERMAL RESISTANCE


Thermal performance is directly linked to printed circuit board (PCB) design and operating environment. Careful attention to PCB thermal design is required.  $\theta_{JA}$  is the natural convection junction to ambient thermal resistance measured in a one cubic foot sealed enclosure.  $\theta_{JC}$  is the junction to case thermal resistance.

Table 6. Thermal Resistance

Package Type	$\theta_{JA}$ <sup>1</sup>	$\theta_{JC}$ <sup>1</sup>	Unit
R-8	110.88	58.63	°C/W
RM-8	165.69	49.61	°C/W
RM-10	165.69	49.61	°C/W
R-14	104.5	42.90	°C/W
CP-10-9	55.65	33.22	°C/W

<sup>1</sup> Thermal impedance simulated values are based on JEDEC 2S2P thermal test board with no bias. See JEDEC JESD-51.

## ESD CAUTION

	<p><b>ESD (electrostatic discharge) sensitive device.</b> Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.</p>
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## PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

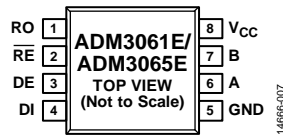


Figure 8. ADM3061E/ADM3065E 8-Lead Narrow Body SOIC\_N Pin Configuration

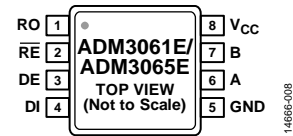
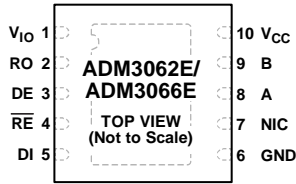


Figure 9. ADM3061E/ADM3065E 8-Lead MSOP Pin Configuration

Table 7. ADM3061E/ADM3065E Pin Function Descriptions

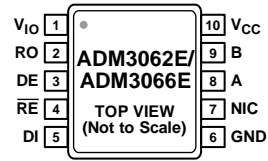
Pin No.	Mnemonic	Description
1	RO	Receiver Output Data. This output is high when $(A - B) \geq -30$ mV and low when $(A - B) \leq -200$ mV. This output is tristated when the receiver is disabled; that is, when $\overline{RE}$ is driven high.
2	$\overline{RE}$	Receiver Enable Input. This is an active low input. Driving this input low enables the receiver, and driving it high disables the receiver.
3	DE	Driver Enable. A high level on this pin enables the driver differential outputs, A and B. A low level places the driver output into a high impedance state.
4	DI	Transmit Data Input. Data to be transmitted by the driver is applied to this input.
5	GND	Ground.
6	A	Noninverting Driver Output and Receiver Input. When the driver is disabled, or when $V_{CC}$ is powered down, Pin A is put into a high impedance state to avoid overloading the bus.
7	B	Inverting Driver Output and Receiver Input. When the driver is disabled, or when $V_{CC}$ is powered down, Pin B is put into a high impedance state to avoid overloading the bus.
8	$V_{CC}$	3.0V to 5.5V Power Supply. Adding a 0.1 $\mu$ F decoupling capacitor between the $V_{CC}$ pin and the GND pin is recommended.



NOTES  
 1. NIC = NO INTERNAL CONNECTION. THIS PIN IS NOT INTERNALLY CONNECTED.  
 2. EXPOSED PAD. THE EXPOSED PAD MUST BE CONNECTED TO GROUND.

1466E-009

Figure 10. ADM3062E/ADM3066E 10-Lead LFCSP Pin Configuration



1. NIC = NO INTERNAL CONNECTION. THIS PIN IS NOT INTERNALLY CONNECTED.

1466E-010

Figure 11. ADM3062E/ADM3066E 10-Lead MSOP Pin Configuration

Table 8. ADM3066E/ADM3062E Pin Function Descriptions

Pin No.	Mnemonic	Description
1	V <sub>IO</sub>	1.62 V to 5.5 V Logic Supply. Adding a 0.1 μF decoupling capacitor between the V <sub>IO</sub> pin and the GND pin is recommended.
2	RO	Receiver Output Data. This output is high when (A – B) ≥ –30 mV and low when (A – B) ≤ –200 mV. This output is tristated when the receiver is disabled; that is, when RE is driven high.
3	DE	Driver Enable. A high level on this pin enables the driver differential outputs, A and B. A low level places the driver output into a high impedance state.
4	$\overline{\text{RE}}$	Receiver Enable Input. This is an active low input. Driving this input low enables the receiver, and driving it high disables the receiver.
5	DI	Transmit Data Input. Data to be transmitted by the driver is applied to this input.
6	GND	Ground.
7	NIC	No Internal Connection. This pin is not internally connected.
8	A	Noninverting Driver Output and Receiver Input. When the driver is disabled, or when V <sub>CC</sub> is powered down, Pin A is put into a high impedance state to avoid overloading the bus.
9	B	Inverting Driver Output and Receiver Input. When the driver is disabled, or when V <sub>CC</sub> is powered down, Pin B is put into a high impedance state to avoid overloading the bus.
10	V <sub>CC</sub> EPAD	3.0V to 5.5 V Power Supply. Adding a 0.1 μF decoupling capacitor between the V <sub>CC</sub> pin and the GND pin is recommended. Exposed Pad. The exposed pad must be connected to ground for the LFCSP package.

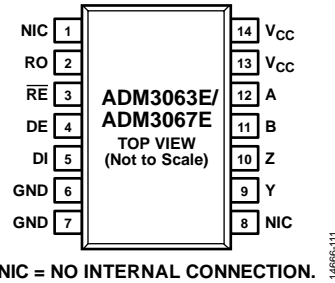


Figure 12. ADM3063E/ADM3067E 14-Lead SOIC Pin Configuration

Table 9. ADM3063E/ADM3067E Pin Function Descriptions

Pin No.	Mnemonic	Description
1, 8	NIC	No Internal Connection. This pin is not internally connected.
2	RO	Receiver Output Data. This output is high when $(A - B) \geq -30$ mV and low when $(A - B) \leq -200$ mV. This output is tristated when the receiver is disabled; that is, when $\overline{RE}$ is driven high.
3	$\overline{RE}$	Receiver Enable Input. This is an active low input. Driving this input low enables the receiver, and driving it high disables the receiver.
4	DE	Driver Enable. A high level on this pin enables the driver differential outputs, Y and Z. A low level places the driver output into a high impedance state.
5	DI	Transmit Data Input. Data to be transmitted by the driver is applied to this input.
6, 7	GND	Ground.
9	Y	Driver Noninverting Output. When the driver is disabled, or when $V_{CC}$ is powered down, Pin Y is put into a high impedance state to avoid overloading the bus.
10	Z	Driver Inverting Output. When the driver is disabled, or when $V_{CC}$ is powered down, Pin Z is put into a high impedance state to avoid overloading the bus.
11	B	Inverting Receiver Input.
12	A	Noninverting Receiver Input.
13, 14	$V_{CC}$	3.0V to 5.5V Power Supply. Adding a 0.1 $\mu$ F decoupling capacitor between the $V_{CC}$ pin and the GND pin is recommended.

### TYPICAL PERFORMANCE CHARACTERISTICS

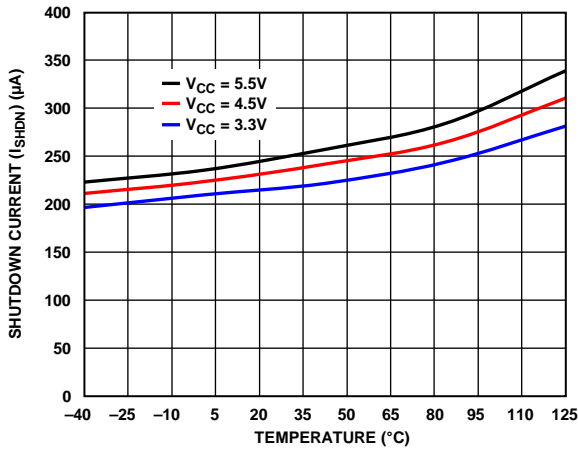


Figure 13. Shutdown Current ( $I_{SHDN}$ ) vs. Temperature

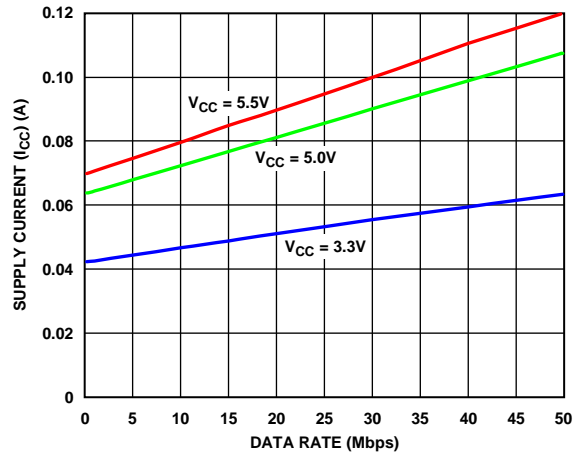


Figure 16. Supply Current ( $I_{CC}$ ) vs. Data Rate with  $54\ \Omega$  Load Resistance, 50 Mbps Models

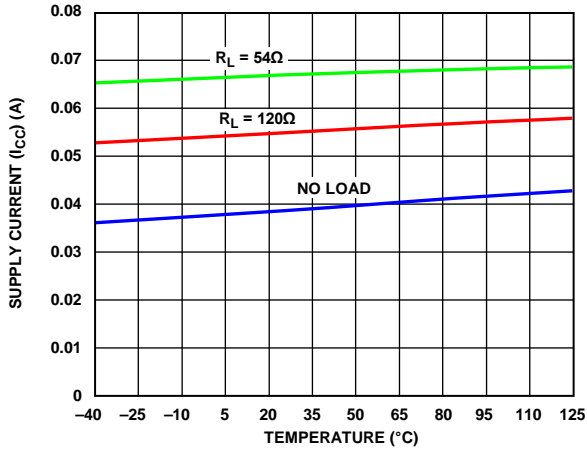


Figure 14. Supply Current ( $I_{CC}$ ) vs. Temperature, Data Rate = 50 Mbps, 50 Mbps Models,  $V_{CC} = 3.3\ V$

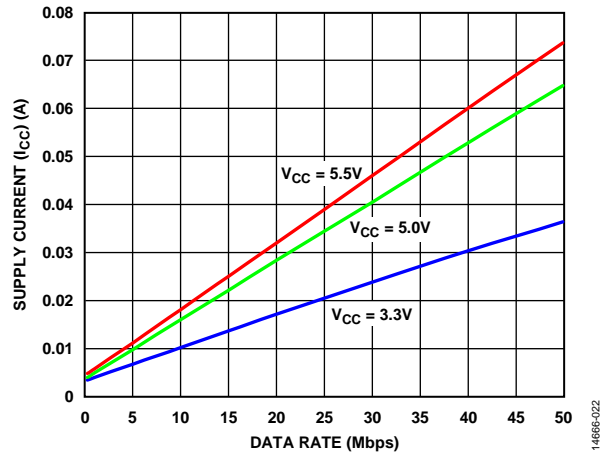


Figure 17. Supply Current ( $I_{CC}$ ) vs. Data Rate with No Load Resistance

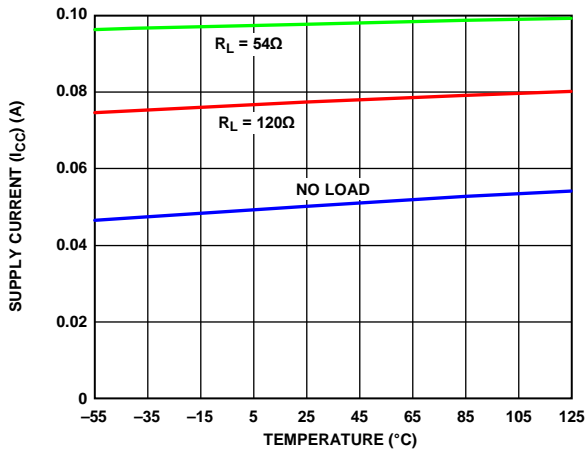


Figure 15. Supply Current ( $I_{CC}$ ) vs. Temperature, Data Rate = 50 Mbps, 50 Mbps Models,  $V_{CC} = 5.0\ V$

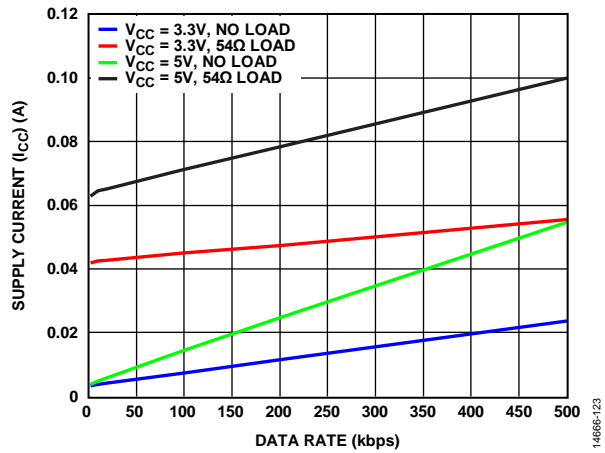


Figure 18. Supply Current ( $I_{CC}$ ) vs. Data Rate with  $54\ \Omega$  Load Resistance and No Load Resistance, 500 kbps Models

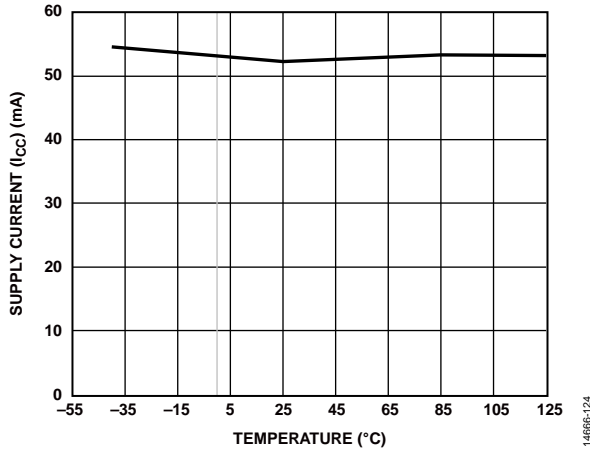


Figure 19. Supply Current ( $I_{CC}$ ) vs. Temperature, Data Rate = 500 kbps, 500 kbps Models,  $V_{CC} = 3.0\text{ V}$

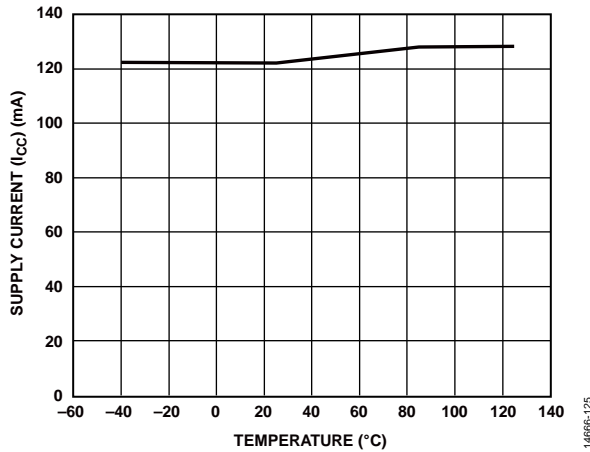


Figure 20. Supply Current ( $I_{CC}$ ) vs. Temperature, Data Rate = 500 kbps, 500 kbps Models,  $V_{CC} = 5.5\text{ V}$

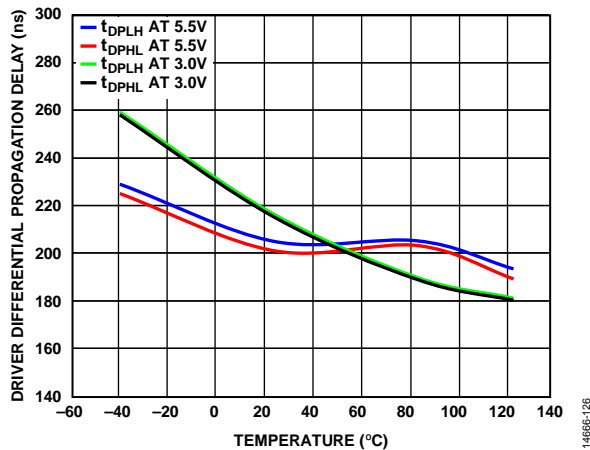


Figure 21. Driver Differential Propagation Delay vs. Temperature, 500 kbps Models

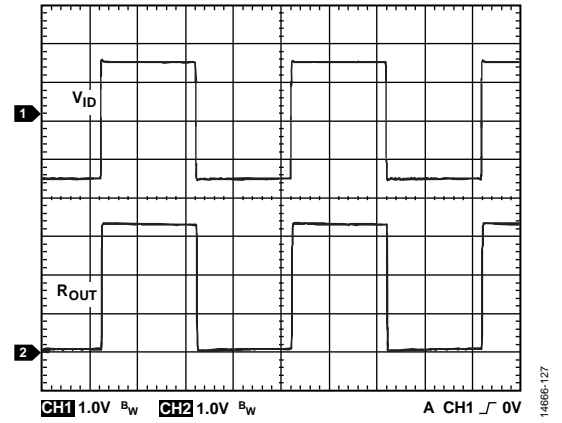


Figure 22. Receiver Propagation Delay (Oscilloscope Plot), Data Rate = 500 kbps,  $V_{ID} \geq 1.5\text{ V}$

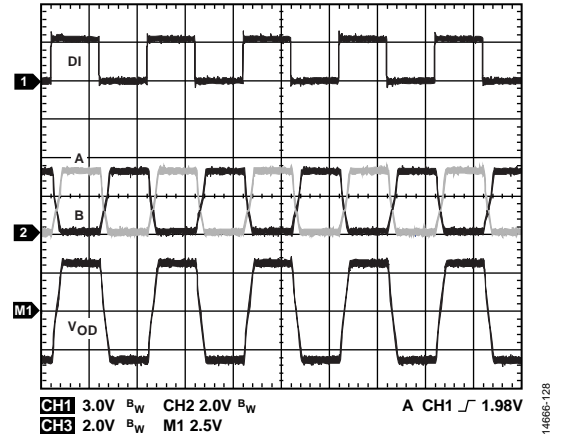


Figure 23. Driver Propagation Delay (Oscilloscope Plot), Data Rate = 500 kbps, 500 kbps Models

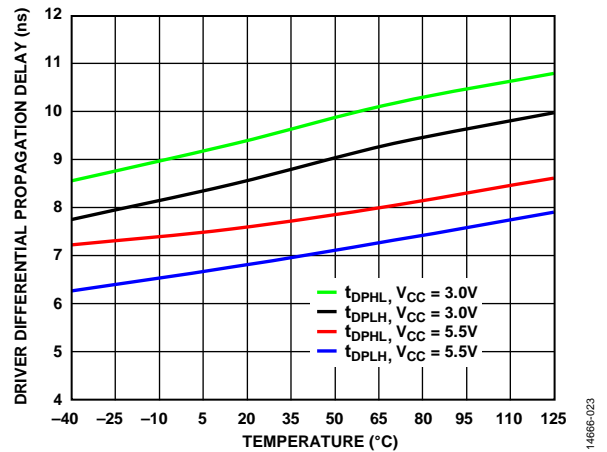


Figure 24. Driver Differential Propagation Delay vs. Temperature, 50 Mbps Models

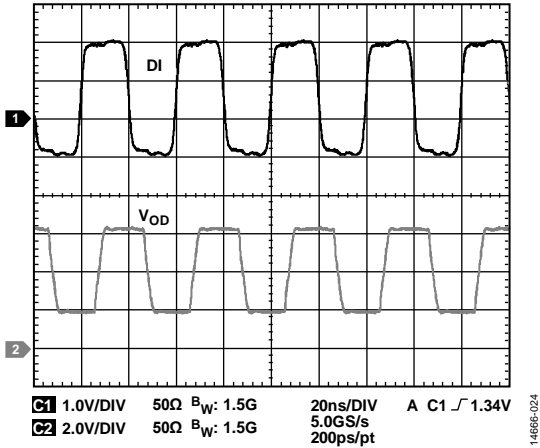


Figure 25. Driver Propagation Delay (Oscilloscope Plot), Data Rate = 50 Mbps, 50 Mbps models

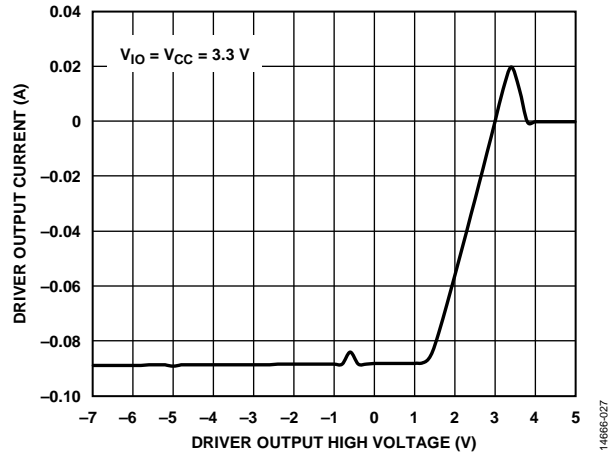


Figure 28. Driver Output Current vs. Driver Output High Voltage

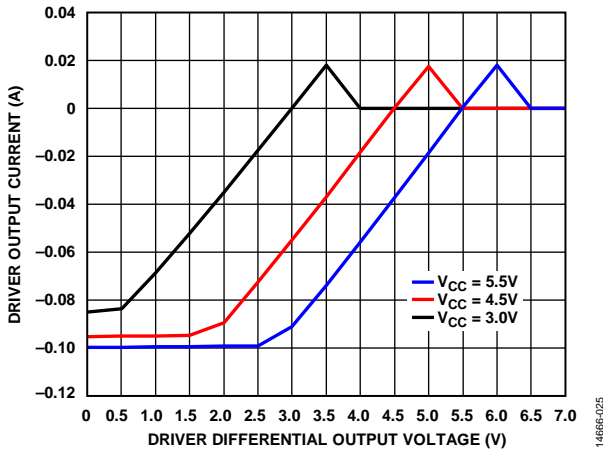


Figure 26. Driver Output Current vs. Driver Differential Output Voltage

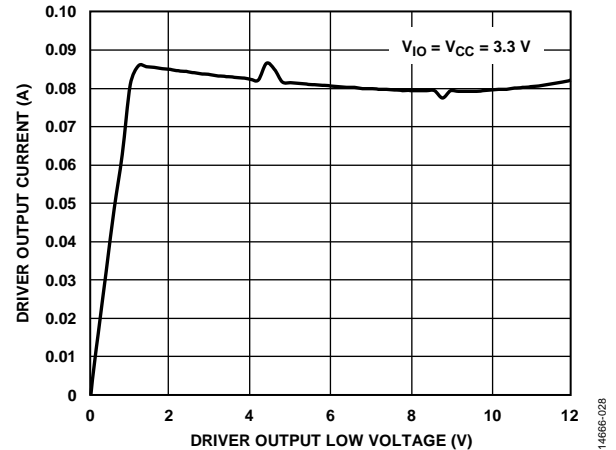


Figure 29. Driver Output Current vs. Driver Output Low Voltage

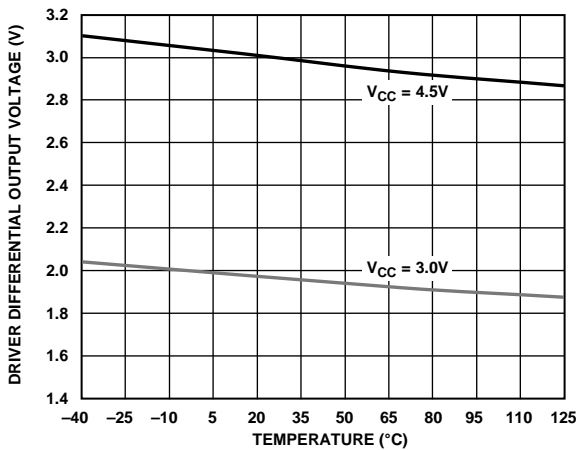


Figure 27. Driver Differential Output Voltage vs. Temperature

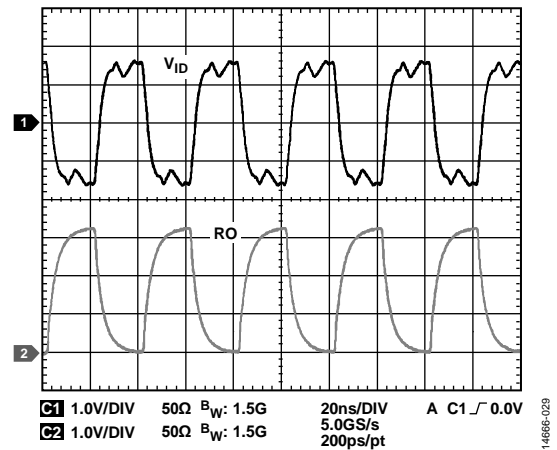


Figure 30. Receiver Propagation Delay at 50 Mbps,  $|V_{ID}| \geq 1.5$  V



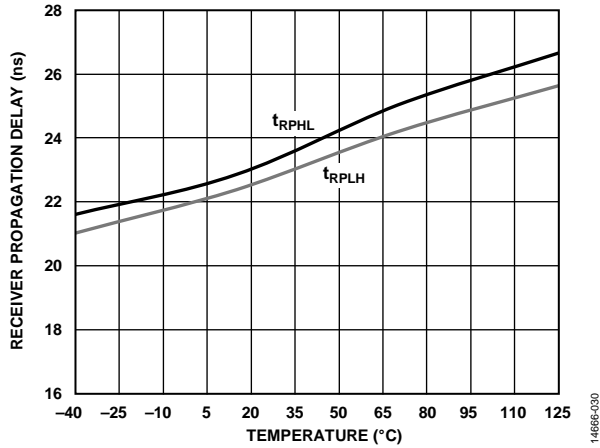


Figure 31. Receiver Propagation Delay vs. Temperature, 50 Mbps

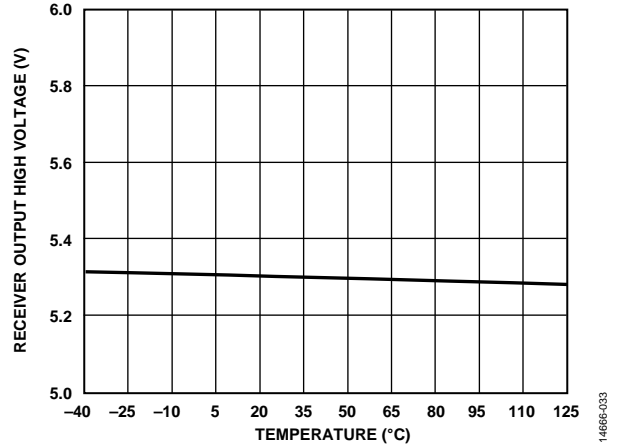


Figure 34. Receiver Output High Voltage vs. Temperature

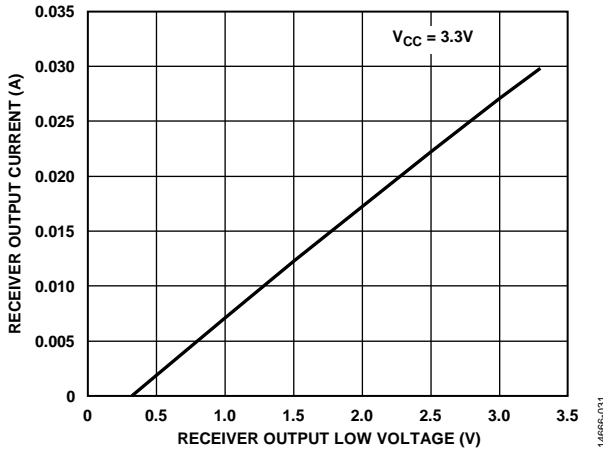


Figure 32. Receiver Output Current vs. Receiver Output Low Voltage ( $V_{CC} = 3.3V$ )

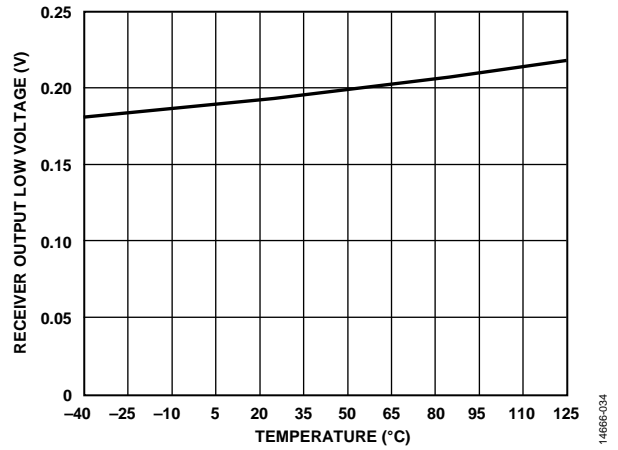


Figure 35. Receiver Output Low Voltage vs. Temperature

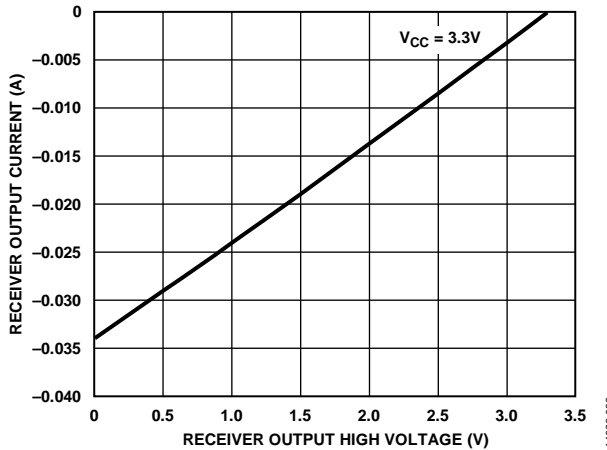


Figure 33. Receiver Output Current vs. Receiver Output High Voltage ( $V_{CC} = 3.3V$ )

TEST CIRCUITS

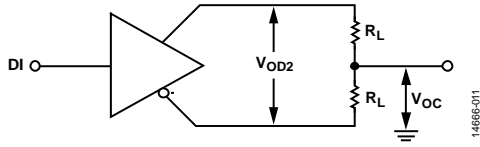


Figure 36. Driver Voltage Measurements

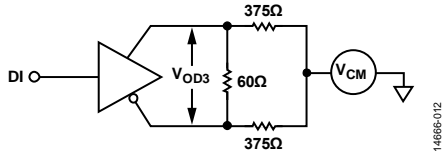


Figure 37. Driver Voltage Measurements over Common-Mode Range

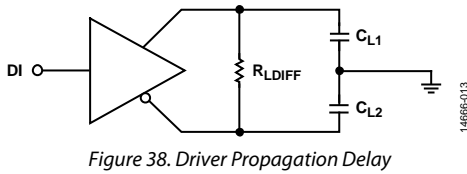


Figure 38. Driver Propagation Delay

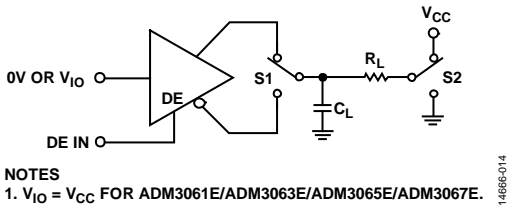


Figure 39. Driver Enable/Disable

NOTES  
1.  $V_{IO} = V_{CC}$  FOR ADM3061E/ADM3063E/ADM3065E/ADM3067E.

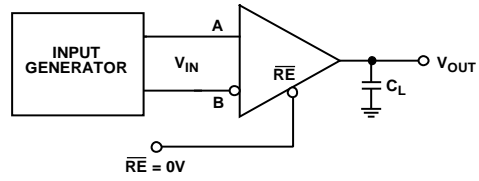
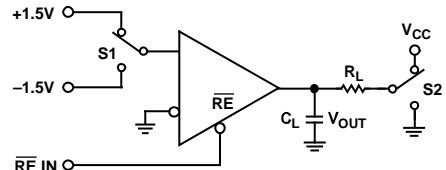
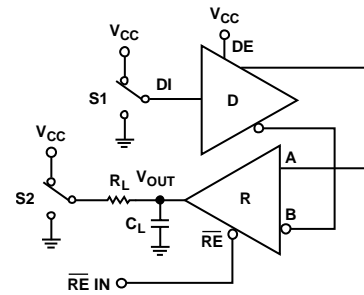


Figure 40. Receiver Propagation Delay/Skew



NOTES  
1.  $V_{CC} = V_{IO}$  FOR ADM3062E/ADM3066E.

Figure 41. Receiver Enable/Disable from Shutdown



NOTES  
1.  $V_{CC} = V_{IO}$  FOR ADM3062E/ADM3066E.

Figure 42. Receiver Enable/Disable

## THEORY OF OPERATION

### IEC ESD PROTECTED RS-485

The ADM3065E/ADM3066E/ADM3067E are 3.0 V to 5.5 V, 50 Mbps RS-485 transceivers with IEC 61000-4-2 Level 4 ESD protection on the bus pins. The ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E can withstand up to  $\pm 12$  kV contact discharge on transceiver bus pins (A, B, Y, and Z) without latch-up or damage. The ADM3061E/ADM3062E/ADM3063E has the same robust IEC 61000-4-2 ESD protection as the ADM3065E/ADM3066E/ADM3067E models and operate at a lower 500 kbps data rate.

### HIGH DRIVER DIFFERENTIAL OUTPUT VOLTAGE

The ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E have characteristics optimized for use in PROFIBUS applications. When powered at  $V_{CC} \geq 4.5$  V, the ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E driver output differential voltage meets or exceeds the PROFIBUS requirements of 2.1 V with a 54  $\Omega$  load.

### IEC 61000-4-2 ESD PROTECTION

ESD is the sudden transfer of electrostatic charge between bodies at different potentials caused by near contact or induced by an electric field. It has the characteristics of high current in a short time period. The primary purpose of the IEC 61000-4-2 test is to determine the immunity of systems to external ESD events outside the system during operation. IEC 61000-4-2 describes testing using two coupling methods: contact discharge and air discharge. Contact discharge implies a direct contact between the discharge gun and the equipment under test (EUT). During air discharge testing, the charged electrode of the discharge gun is moved toward the EUT until a discharge occurs as an arc across the air gap. The discharge gun does not make direct contact with the EUT. A number of factors affect the results and repeatability of the air discharge test, including humidity, temperature, barometric pressure, distance, and rate of approach to the EUT. This method is a more accurate representation of an actual ESD event but is not as repeatable. Therefore, contact discharge is the preferred test method.

During testing, the data port is subjected to at least 10 positive and 10 negative single discharges. Selection of the test voltage is dependent on the system end environment.

Figure 43 shows the 8 kV contact discharge current waveform as described in the IEC 61000-4-2 specification. Some of the key waveform parameters are rise times of less than 1 ns and pulse widths of approximately 60 ns.

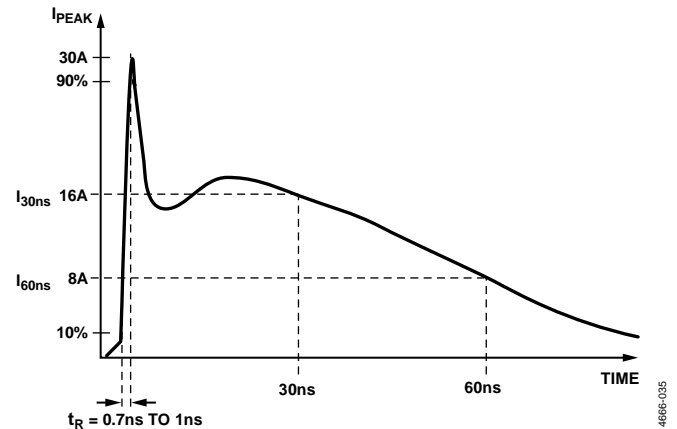


Figure 43. IEC 61000-4-2 ESD Waveform (8 kV)

Figure 44 shows the 8 kV contact discharge current waveform from the IEC 61000-4-2 standard compared to the HBM ESD 8 kV waveform. Figure 44 shows that the two standards specify a different waveform shape and peak current. The peak current associated with an IEC 61000-4-2 8 kV pulse is 30 A, whereas the corresponding peak current for HBM ESD is more than five times less, at 5.33 A. The other difference is the rise time of the initial voltage spike, with the IEC 61000-4-2 ESD waveform having a much faster rise time of 1 ns, compared to the 10 ns associated with the HBM ESD waveform. The amount of power associated with an IEC ESD waveform is much greater than that of an HBM ESD waveform. The HBM ESD standard requires the EUT to be subjected to three positive and three negative discharges, whereas the IEC ESD standard requires 10 positive and 10 negative discharge tests.

The ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E with IEC 61000-4-2 ESD ratings is better suited for operation in harsh environments compared to other RS-485 transceivers that state varying levels of HBM ESD protection.

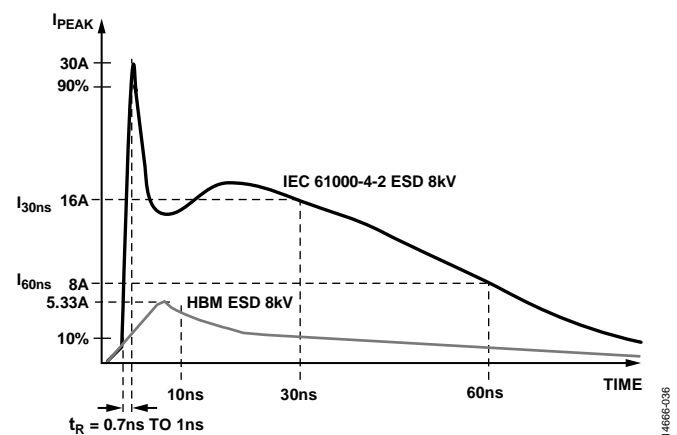


Figure 44. IEC 61000-4-2 ESD Waveform 8 kV Compared to HBM ESD Waveform 8 kV

**TRUTH TABLES**

Table 11 and Table 12 use the abbreviations shown in Table 10.

**Table 10. Truth Table Abbreviations**

Letter	Description
H	High level
I	Indeterminate
L	Low level
X	Any state
Z	High Impedance (Off)

**Table 11. Transmitting Truth Table**

Supply Status		Inputs			Outputs	
V <sub>IO</sub> <sup>1</sup>	V <sub>CC</sub>	$\overline{RE}$	DE	DI	A/Y	B/Z
On	On	X	H	H	H	L
On	On	X	H	L	L	H
On	On	X	L	X	Z	Z
Off	On	X	X	X	I	I
On	Off	X	X	X	Z	Z
Off	Off	X	X	X	Z	Z

<sup>1</sup> For the ADM3061E, ADM3063E, ADM3065E, and ADM3067E, the V<sub>IO</sub> pin is not applicable.

**Table 12. Receiving Truth Table**

Supply Status		Inputs			Outputs	
V <sub>IO</sub> <sup>1</sup>	V <sub>CC</sub>	A – B		$\overline{RE}$	DE	RO
On	On	>–0.03 V		L	X	H
On	On	<–0.2 V		L	X	L
On	On	–0.2 V ≤ A – B ≤ –0.03 V		L	X	I
On	On	Inputs open/shorted		L	X	H
On	On	X		H	X	Z
On	Off	X		L	X	I
On	Off	X		H	X	Z
Off	On	X		L	X	I
Off	Off	X		X	X	I

<sup>1</sup> For the ADM3061E, ADM3063E, ADM3065E, and ADM3067E, the V<sub>IO</sub> pin is not applicable.

**RECEIVER FAIL-SAFE**

The ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E guarantee a logic high receiver output when the receiver inputs are shorted, open, or connected to a terminated transmission line with all drivers disabled. This receiver output is achieved by setting the receiver input threshold between –30 mV and –200 mV. If the differential receiver input voltage (A – B) is greater than or equal to –30 mV, the RO pin is logic high.

If the A – B input is less than or equal to –200 mV, RO is logic low. In the case of a shorted, open circuit or terminated bus with all transmitters disabled, the receiver differential input voltage is pulled to 0 V, resulting in a logic high with a 30 mV minimum noise margin.

**HOT SWAP CAPABILITY**

When a circuit board is inserted into a powered (or hot) backplane, differential disturbances to the data bus can lead to data errors. During this period, processor logic output drivers are high impedance and are unable to drive the DE and RE inputs of the RS-485 transceivers to a defined logic level. Leakage currents up to ±10 μA from the high impedance state of the processor logic drivers can cause standard complementary metal-oxide semiconductor (CMOS) enable inputs of a transceiver to drift to an incorrect logic level. Additionally, parasitic circuit board capacitance can cause coupling of V<sub>CC</sub> or GND to the enable inputs. Without the hot swap capability, these factors can improperly enable the driver or receiver of the transceiver. When V<sub>CC</sub> or V<sub>IO</sub> rises, an internal pull-down circuit holds DE low and RE high. After the initial power-up sequence, the pull-down circuit becomes transparent resetting the hot swap tolerable input.

**128 TRANSCEIVERS ON THE BUS**

The standard RS-485 receiver input impedance is 12 kΩ (one unit load), and the standard driver can drive up to 32 unit loads. The ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E transceivers have a one fourth unit load receiver input impedance (48 kΩ), allowing up to 128 transceivers to be connected in parallel on one communication line. Any combination of these devices and other RS-485 transceivers with a total of 32 unit loads or fewer can be connected to the line.

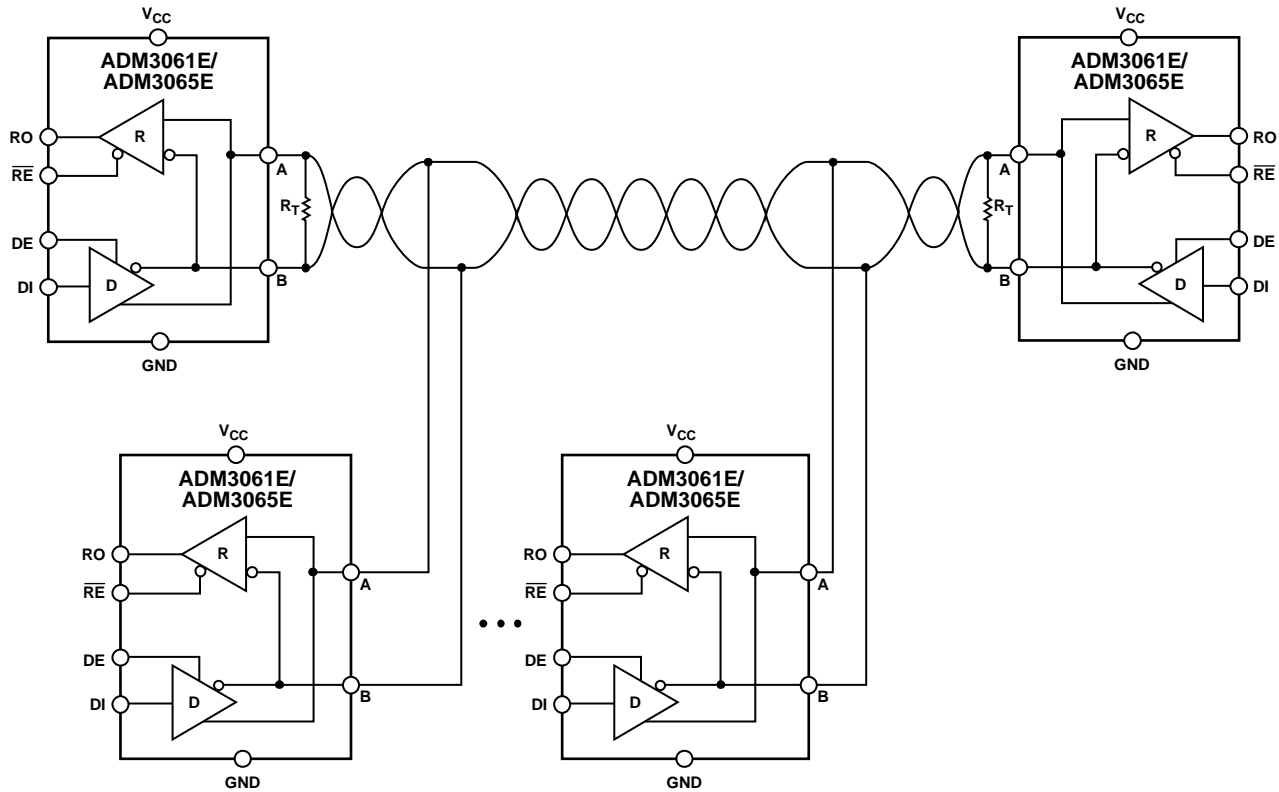
**DRIVER OUTPUT PROTECTION**

The ADM3061E/ADM3062E/ADM3063E/ADM3065E/ADM3066E/ADM3067E feature two methods to prevent excessive output current and power dissipation caused by faults or by bus contention. Current-limit protection on the output stage provides immediate protection against short circuits over the whole common-mode voltage range. In addition, a thermal shutdown circuit forces the driver outputs into a high impedance state if the die temperature rises excessively. This circuitry is designed to disable the driver outputs when a die temperature of 150°C is reached. As the device cools, the drivers are reenabled at a temperature of 140°C.

## APPLICATIONS INFORMATION

The ADM3061E/ADM3065E transceiver is designed for bidirectional data communications on multipoint bus transmission lines. Figure 45 shows a typical network applications circuit.

To minimize reflections, terminate the line at both ends with a termination resistor (the value of the termination resistor must be equal to the characteristic impedance of the cable used) and keep stub lengths off the main line as short as possible.



### NOTES

1. THE MAXIMUM NUMBER OF NODES IS 128.
2.  $R_T$  IS EQUAL TO THE CHARACTERISTIC IMPEDANCE OF THE CABLE USED.

Figure 45. ADM3061E/ADM3065E Typical Half-Duplex RS-485 Communications Network

**ISOLATED HIGH SPEED RS-485 NODE**

Galvanic isolation, with reinforced insulation and 5 kV rms transient withstand voltage, can be added to the ADM3065E using Analog Devices, Inc., *iCoupler*® and *isoPower*® technology. The ADuM6401 provides the required quad channels of 5 kV rms signal isolation, operating at rates up to 25 Mbps, together with an integrated dc-to-dc converter. The ADuM6401 combines with the ADM3065E (shown in Figure 46) with the V<sub>ISO</sub> pin configured for 3.3 V by connecting the V<sub>SEL</sub> pin to GND<sub>ISO</sub> and a 5 V supply connected to V<sub>DD1</sub>. Operation at 3.3 V ensures the ADM3065E remains within the load capability of ADuM6401 even at 25 Mbps.

The dc-to-dc converter in the ADuM6401 *isoPower* device provides regulated, isolated power to the ADM3065E (and the

ADuM241D). These *isoPower* devices use high frequency switching elements to transfer power through the transformers. Take care during PCB layout to meet emissions standards. See the AN-0971 Application Note for PCB layout recommendations.

Operation at up to 50 Mbps data rates with isolation of the ADM3065E can be implemented using the ADuM241D quad-channel digital isolator and the ADuM6028 isolated dc-to-dc converter, as shown in Figure 47. The ADuM241D can operate at a data rate of up to 150 Mbps, offering the precise timing required to fully support the ADM3065E at 50 Mbps. Operation of the ADM3065E at 3.3 V allows operation at the 50 Mbps data rate.

The ADuM6028 is an 8-pin device that contains a 300 mW dc-to-dc converter optimized to meet emissions standards on a 2-layer PCB using two ferrite beads.

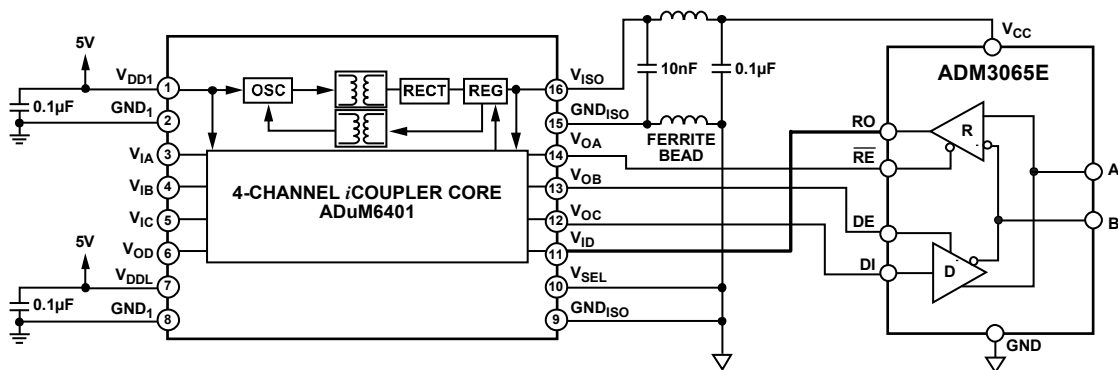


Figure 46. Signal and Power Isolated 25 Mbps RS-485 Solution (Simplified Diagram—All Connections Not Shown)

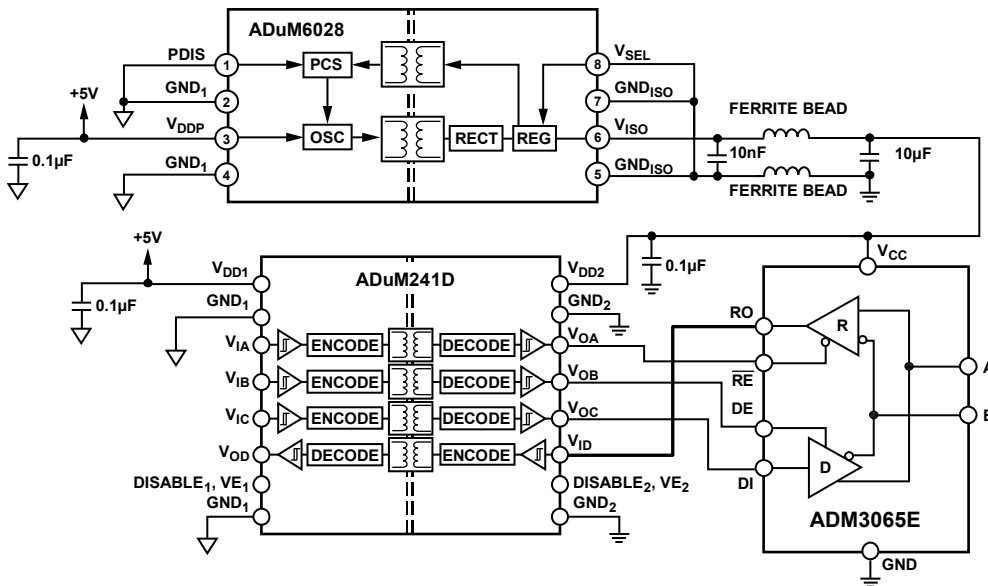
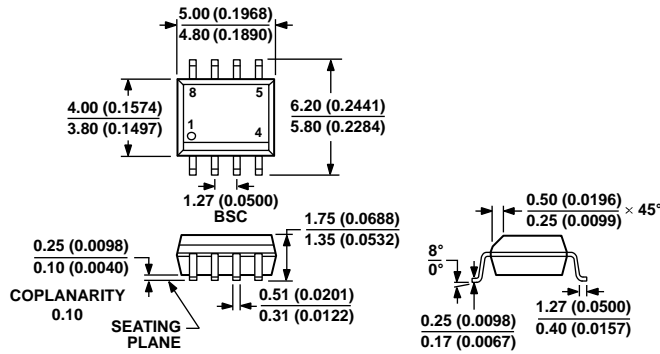


Figure 47. Signal and Power Isolated 50 Mbps RS-485 Solution (Simplified Diagram—All Connections Not Shown)

# OUTLINE DIMENSIONS

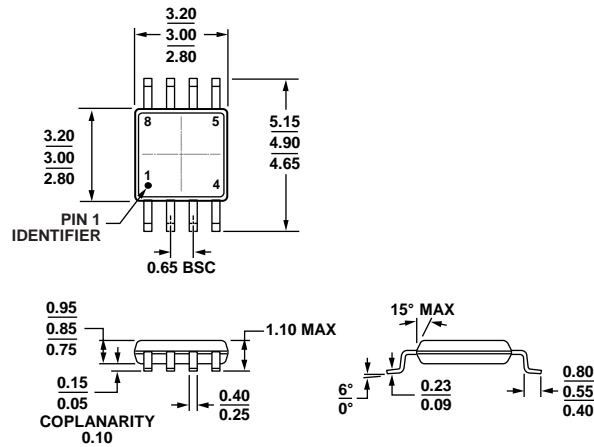


COMPLIANT TO JEDEC STANDARDS MS-012-AA  
 CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS  
 (IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR  
 REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

012A07-A

Figure 48. 8-Lead Standard Small Outline Package [SOIC\_N]  
 Narrow Body  
 (R-8)

Dimensions shown in millimeters and (inches)

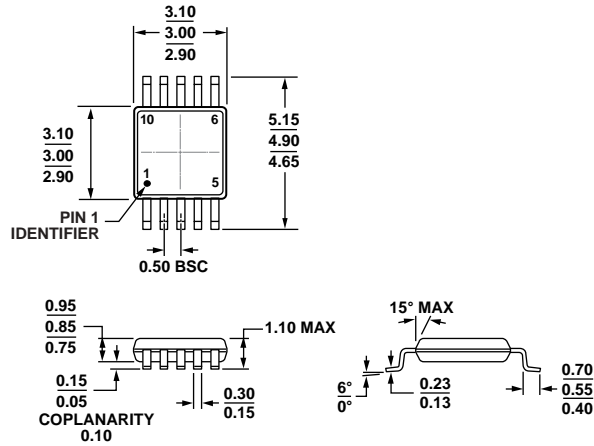


COMPLIANT TO JEDEC STANDARDS MO-187-AA

Figure 49. 8-Lead Mini Small Outline Package [MSOP]  
 (RM-8)

Dimensions shown in millimeters

10-07-2008-B



COMPLIANT TO JEDEC STANDARDS MO-187-BA

Figure 50. 10-Lead Mini Small Outline Package [MSOP] (RM-10)

Dimensions shown in millimeters

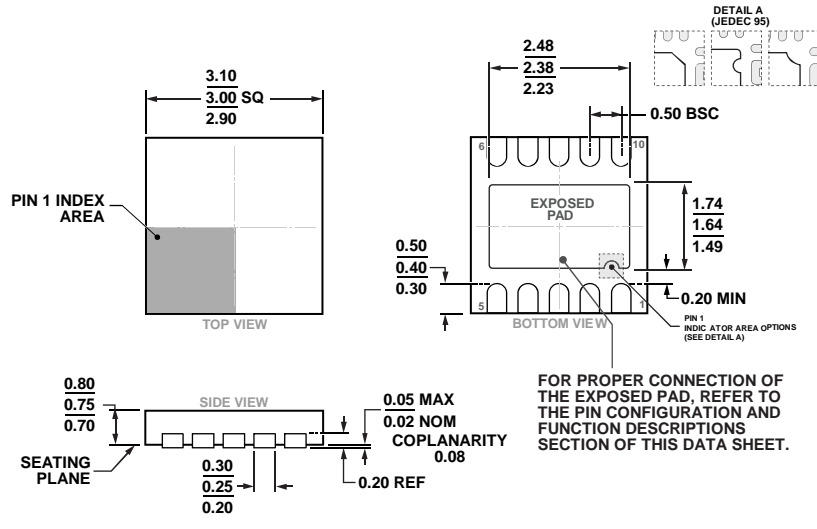
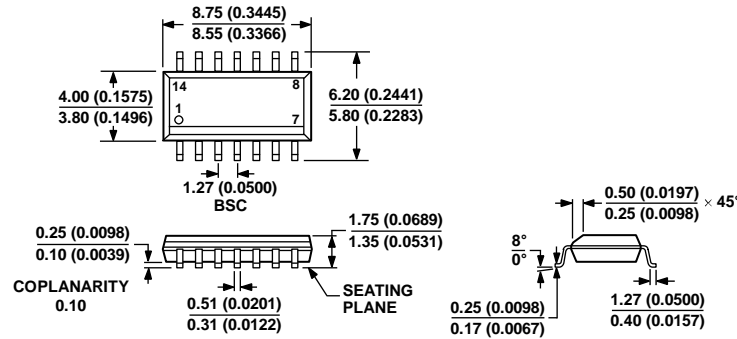


Figure 51. 10-Lead Lead Frame Chip Scale Package [LFCSPP] 3 mm x 3 mm Body and 0.75 mm Package Height (CP-10-9)

Dimensions shown in millimeters





COMPLIANT TO JEDEC STANDARDS MS-012-AB  
 CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS  
 (IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR  
 REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

060606-A

Figure 52. 14-Lead Standard Small Outline Package [SOIC\_N]  
 Narrow Body  
 (R-14)

Dimensions shown in millimeters and (inches)

**ORDERING GUIDE**

Model <sup>1</sup>	Temperature Range	Package Description	Package Option	Marking Code
ADM3061EARZ	-40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM3061EARZ-R7	-40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM3061EBRZ	-40°C to +125°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM3061EBRZ-R7	-40°C to +125°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM3061EARMZ	-40°C to +85°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	MBY
ADM3061EARMZ-R7	-40°C to +85°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	MBY
ADM3061EBRMZ	-40°C to +125°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	MC0
ADM3061EBRMZ-R7	-40°C to +125°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	MC0
ADM3062EACPZ	-40°C to +85°C	10-Lead Lead Frame Chip Scale Package [LFCSP]	CP-10-9	MCC
ADM3062EACPZ-R7	-40°C to +85°C	10-Lead Lead Frame Chip Scale Package [LFCSP]	CP-10-9	MCC
ADM3062EBCPZ	-40°C to +125°C	10-Lead Lead Frame Chip Scale Package [LFCSP]	CP-10-9	MCD
ADM3062EBCPZ-R7	-40°C to +125°C	10-Lead Lead Frame Chip Scale Package [LFCSP]	CP-10-9	MCD
ADM3062EARMZ	-40°C to +85°C	10-Lead Mini Small Outline Package [MSOP]	RM-10	MC7
ADM3062EARMZ-R7	-40°C to +85°C	10-Lead Mini Small Outline Package [MSOP]	RM-10	MC7
ADM3062EBRMZ	-40°C to +125°C	10-Lead Mini Small Outline Package [MSOP]	RM-10	MC8
ADM3062EBRMZ-R7	-40°C to +125°C	10-Lead Mini Small Outline Package [MSOP]	RM-10	MC8
ADM3063EARZ	-40°C to +85°C	14-Lead Standard Small Outline Package [SOIC_N]	R-14	
ADM3063EARZ-R7	-40°C to +85°C	14-Lead Standard Small Outline Package [SOIC_N]	R-14	
ADM3063EBRZ	-40°C to +125°C	14-Lead Standard Small Outline Package [SOIC_N]	R-14	
ADM3063EBRZ-R7	-40°C to +125°C	14-Lead Standard Small Outline Package [SOIC_N]	R-14	
ADM3065EARZ	-40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM3065EARZ-R7	-40°C to +85°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM3065EBRZ	-40°C to +125°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM3065EBRZ-R7	-40°C to +125°C	8-Lead Standard Small Outline Package [SOIC_N]	R-8	
ADM3065EARMZ	-40°C to +85°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	MC1
ADM3065EARMZ-R7	-40°C to +85°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	MC1
ADM3065EBRMZ	-40°C to +125°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	MC2
ADM3065EBRMZ-R7	-40°C to +125°C	8-Lead Mini Small Outline Package [MSOP]	RM-8	MC2

<b>Model<sup>1</sup></b>	<b>Temperature Range</b>	<b>Package Description</b>	<b>Package Option</b>	<b>Marking Code</b>
ADM3066EACPZ	-40°C to +85°C	10-Lead Lead Frame Chip Scale Package [LFCSP]	CP-10-9	MC9
ADM3066EACPZ-R7	-40°C to +85°C	10-Lead Lead Frame Chip Scale Package [LFCSP]	CP-10-9	MC9
ADM3066EBCPZ	-40°C to +125°C	10-Lead Lead Frame Chip Scale Package [LFCSP]	CP-10-9	MCA
ADM3066EBCPZ-R7	-40°C to +125°C	10-Lead Lead Frame Chip Scale Package [LFCSP]	CP-10-9	MCA
ADM3066EARMZ	-40°C to +85°C	10-Lead Mini Small Outline Package [MSOP]	RM-10	MC4
ADM3066EARMZ-R7	-40°C to +85°C	10-Lead Mini Small Outline Package [MSOP]	RM-10	MC4
ADM3066EBRMZ	-40°C to +125°C	10-Lead Mini Small Outline Package [MSOP]	RM-10	MC5
ADM3066EBRMZ-R7	-40°C to +125°C	10-Lead Mini Small Outline Package [MSOP]	RM-10	MC5
ADM3067EARZ	-40°C to +85°C	14-Lead Standard Small Outline Package [SOIC_N]	R-14	
ADM3067EARZ-R7	-40°C to +85°C	14-Lead Standard Small Outline Package [SOIC_N]	R-14	
ADM3067EBRZ	-40°C to +125°C	14-Lead Standard Small Outline Package [SOIC_N]	R-14	
ADM3067EBRZ-R7	-40°C to +125°C	14-Lead Standard Small Outline Package [SOIC_N]	R-14	
EVAL-ADM3061EEBZ		8-Lead SOIC Evaluation Board		
EVAL-ADM3061EEB1Z		8-Lead MSOP Evaluation Board		
EVAL-ADM3062EEBZ		10-Lead MSOP Evaluation Board		
EVAL-ADM3062EEB1Z		10-Lead LFCSP Evaluation Board		
EVAL-ADM3063EEBZ		14-Lead SOIC Evaluation Board		
EVAL-ADM3065EEBZ		8-Lead SOIC Evaluation Board		
EVAL-ADM3065EEB1Z		8-Lead MSOP Evaluation Board		
EVAL-ADM3066EEBZ		10-Lead MSOP Evaluation Board		
EVAL-ADM3066EEB1Z		10-Lead LFCSP Evaluation Board		
EVAL-ADM3067EEBZ		14-Lead SOIC Evaluation Board		

<sup>1</sup> Z = RoHS Compliant Part.